## Notice of References Cited

Application/Control No. Applicant(s)/Patent Under Reexamination 10/562,033 ZEER, ROBERT L. Examiner Art Unit Page 1 of 1 John M. DeBoer 4112

## U.S. PATENT DOCUMENTS

		Document Number	Date		
*		Country Code-Number-Kind Code	MM-YYYY	Name	Classification
*	Α	US-5,103,921 A	04-1992	Zeer et al.	175/81
*	В	US-5,163,522 A	11-1992	Eaton et al.	175/58
*	С	US-5,188,190 A	02-1993	Skaalure, Eric W.	175/58
*	D	US-5,211,715 A	05-1993	Braden et al.	175/58
*	Е	US-5,568,838 A	10-1996	Struthers et al.	175/246
*	F	US-6,066,844 A	05-2000	Ford et al.	250/227.21
*	G	US-6,474,415 B1	11-2002	Ohmer, Herve	166/297
*	Н	US-2006/0231258 A1	10-2006	Head et al.	166/298
	1	US-			
	J	US-			
	к	US-			
	٦	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2.234.278 A	01-1991	UK	Zeer	E21B 7/08
	0					
	Р					
	Q					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	International Search Report (ISR), Dabrowski, Edward (CA), 03/24/2005, pgs. 2-3		
	v			
	w			
	x			

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.